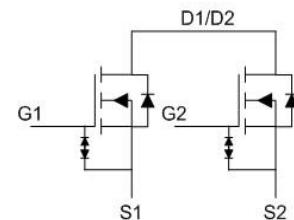


General Description

The LM4D8809 is the highest performance trench N-ch MOSFETs with extreme high cell density, which provide excellent RDSON and gate charge for most of the small power switching and load switch applications. They meet the RoHS and Product requirement with full function reliability approved.



General Features

$V_{DS} = 20V$ $I_D = 9.5A$

$R_{DS(ON)} < 9m\Omega$ @ $V_{GS}=4.5V$

$R_{DS(ON)} < 13.5m\Omega$ @ $V_{GS}=2.5V$

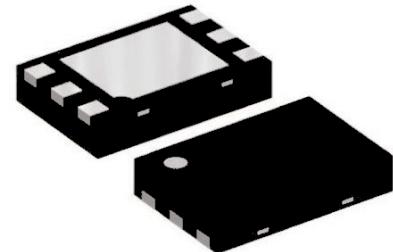
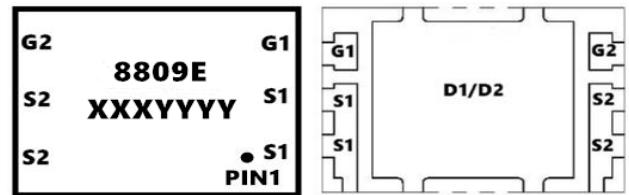
ESD=2KV HBM

Application

Battery protection

Load switch

Uninterruptible power supply



Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
LM4D8809	DFN2*3-6	8809E	3000

Absolute Maximum Ratings ($T_A=25^\circ C$ unless otherwise noted)

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	20	V
V_{GS}	Gate-Source Voltage	± 12	V
$I_D@T_A=25^\circ C$	Continuous Drain Current, $V_{GS} @ 4.5V^1$	9.5	A
$I_D@T_A=70^\circ C$	Continuous Drain Current, $V_{GS} @ 4.5V^1$	7.6	A
I_{DM}	Pulsed Drain Current ²	60	A
$P_D@T_A=25^\circ C$	Total Power Dissipation ¹	1.56	W
T_{STG}	Storage Temperature Range	-55 to 150	°C
T_J	Operating Junction Temperature Range	-55 to 150	°C
$R_{\theta JA}$	Thermal Resistance Junction-Ambient ¹ ($t \leq 10s$)	80	°C/W

N-Channel Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$\text{V}_{\text{GS}}=0\text{V}$, $\text{I}_D=250\mu\text{A}$	20	---	---	V
$\text{R}_{\text{DS(ON)}}$	Static Drain-Source On-Resistance ²	$\text{V}_{\text{GS}}=4.5\text{V}$, $\text{I}_D=5\text{A}$	6.3	7.8	9	$\text{m}\Omega$
		$\text{V}_{\text{GS}}=4.0\text{V}$, $\text{I}_D=5\text{A}$	6.5	8.0	9.5	
		$\text{V}_{\text{GS}}=3.7\text{V}$, $\text{I}_D=5\text{A}$	6.7	8.2	10	
		$\text{V}_{\text{GS}}=3.1\text{V}$, $\text{I}_D=5\text{A}$	7.1	8.7	11.2	
		$\text{V}_{\text{GS}}=2.5\text{V}$, $\text{I}_D=5\text{A}$	8.0	10.5	13.5	
$\text{V}_{\text{GS(th)}}$	Gate Threshold Voltage	$\text{V}_{\text{GS}}=\text{V}_{\text{DS}}$, $\text{I}_D=250\mu\text{A}$	0.45	---	1.5	V
I_{DSS}	Drain-Source Leakage Current	$\text{V}_{\text{DS}}=16\text{V}$, $\text{V}_{\text{GS}}=0\text{V}$, $\text{T}_J=25^\circ\text{C}$	---	---	1	uA
		$\text{V}_{\text{DS}}=16\text{V}$, $\text{V}_{\text{GS}}=0\text{V}$, $\text{T}_J=55^\circ\text{C}$	---	---	5	
I_{GSS}	Gate-Source Leakage Current	$\text{V}_{\text{GS}}=\pm 12\text{V}$, $\text{V}_{\text{DS}}=0\text{V}$	---	---	± 10	uA
g_{fs}	Forward Transconductance	$\text{V}_{\text{DS}}=5\text{V}$, $\text{I}_D=5.5\text{A}$	---	38	---	S
Q_{g}	Total Gate Charge (4.5V)	$\text{V}_{\text{DS}}=15\text{V}$, $\text{V}_{\text{GS}}=4.5\text{V}$, $\text{I}_D=5.5\text{A}$	---	22	---	nC
Q_{gs}	Gate-Source Charge		---	3.1	---	
Q_{gd}	Gate-Drain Charge		---	8.2	---	
$\text{T}_{\text{d(on)}}$	Turn-On Delay Time	$\text{V}_{\text{DD}}=15\text{V}$, $\text{V}_{\text{GS}}=4.5\text{V}$, $\text{R}_{\text{G}}=6\text{k}\Omega$, $\text{I}_D=5.5\text{A}$	---	10	---	ns
T_r	Rise Time		---	39.5	---	
$\text{T}_{\text{d(off)}}$	Turn-Off Delay Time		---	65	---	
T_f	Fall Time		---	30	---	
C_{iss}	Input Capacitance	$\text{V}_{\text{DS}}=10\text{V}$, $\text{V}_{\text{GS}}=0\text{V}$, $f=1\text{MHz}$	---	1647	---	pF
C_{oss}	Output Capacitance		---	170	---	
C_{rss}	Reverse Transfer Capacitance		---	148	---	
I_{s}	Continuous Source Current ¹	$\text{V}_{\text{G}}=\text{V}_{\text{D}}=0\text{V}$, Force Current	---	---	9.5	A
I_{SM}	Pulsed Source Current ²		---	---	60	A
V_{SD}	Diode Forward Voltage ²	$\text{V}_{\text{GS}}=0\text{V}$, $\text{I}_s=9.5\text{A}$, $\text{T}_J=25^\circ\text{C}$	---	---	1.2	V

Note :

1 . The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper, $t \leq 10\text{s}$.2.The data tested by pulsed , pulse width $\leq 10\text{us}$, duty cycle $\leq 1\%$

Typical Characteristics

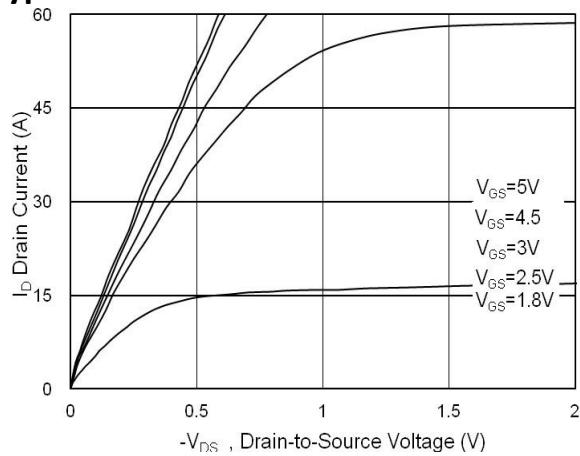


Fig.1 Typical Output Characteristics

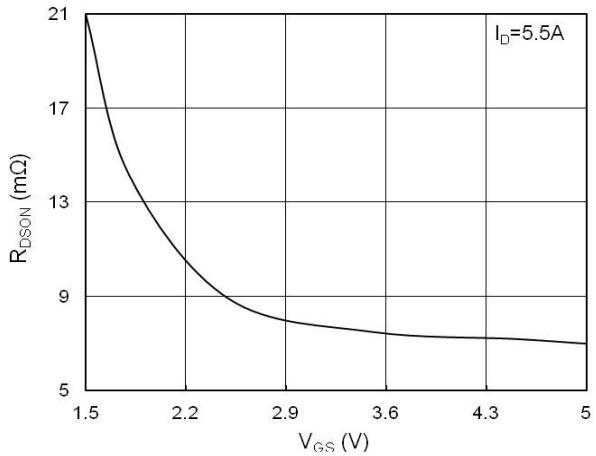


Fig.2 On-Resistance vs. Gate-Source

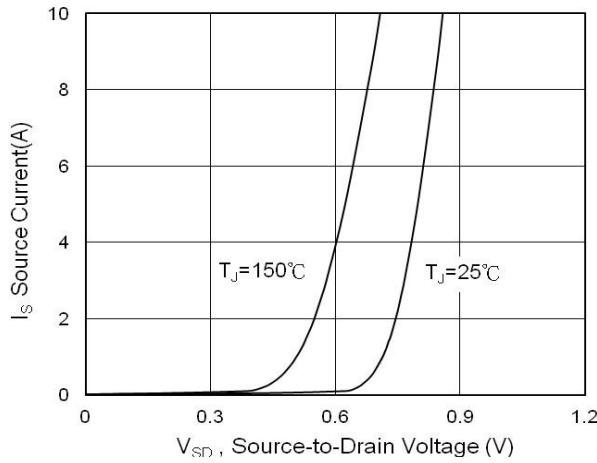


Fig.3 Forward Characteristics Of Reverse

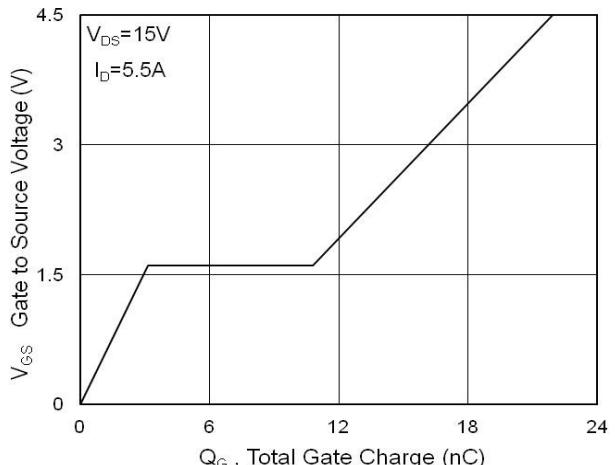


Fig.4 Gate-Charge Characteristics

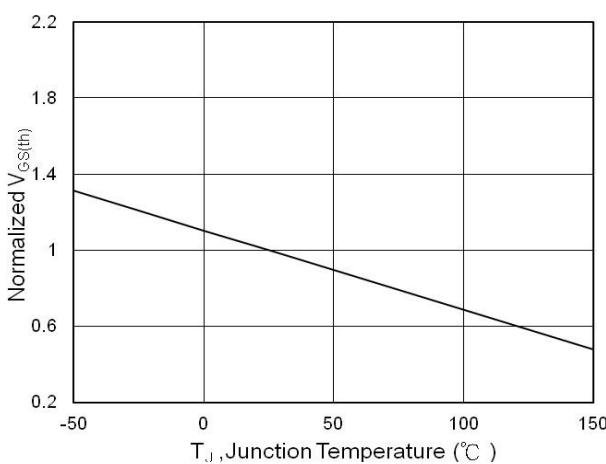


Fig.5 $V_{GS(th)}$ vs. T_J

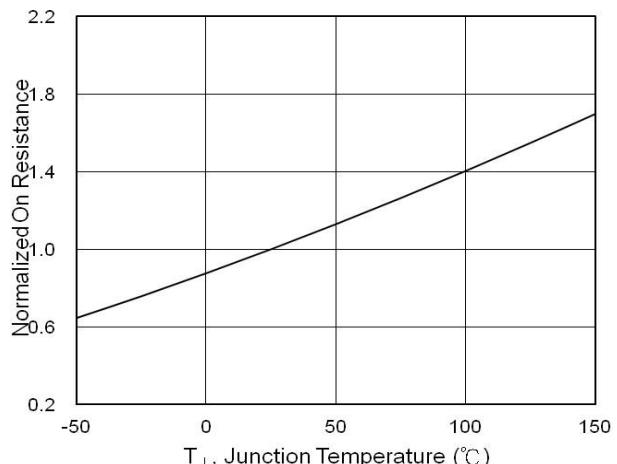
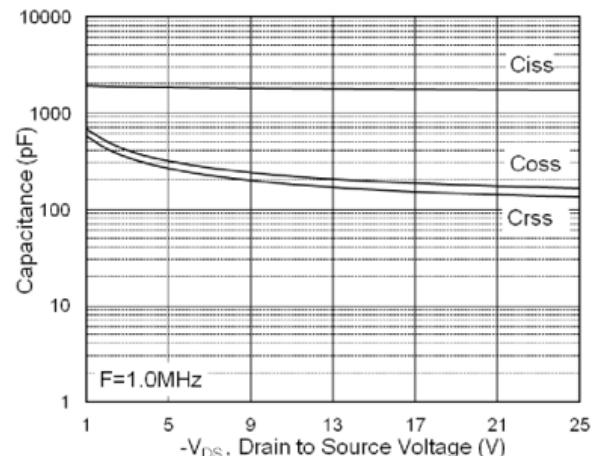
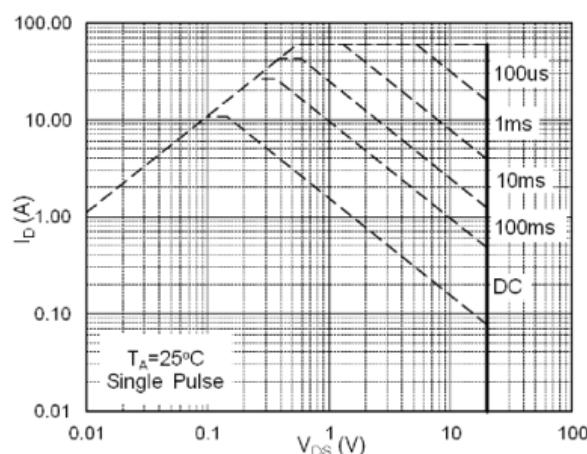
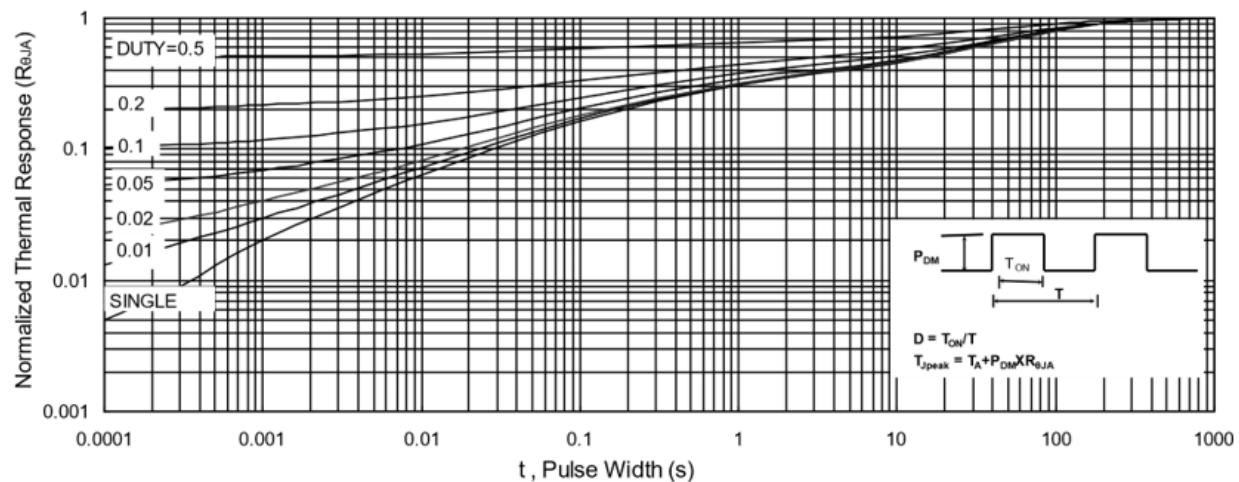
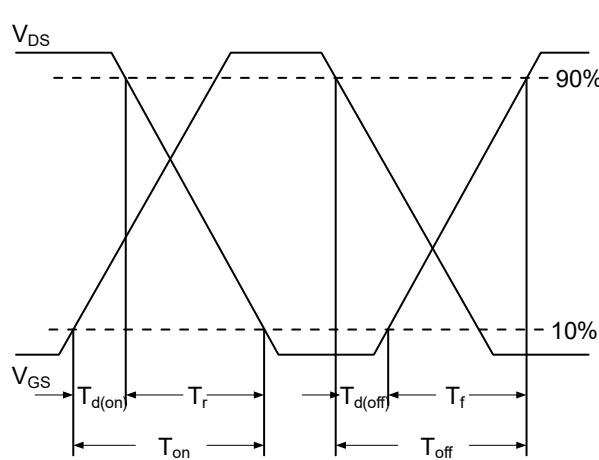
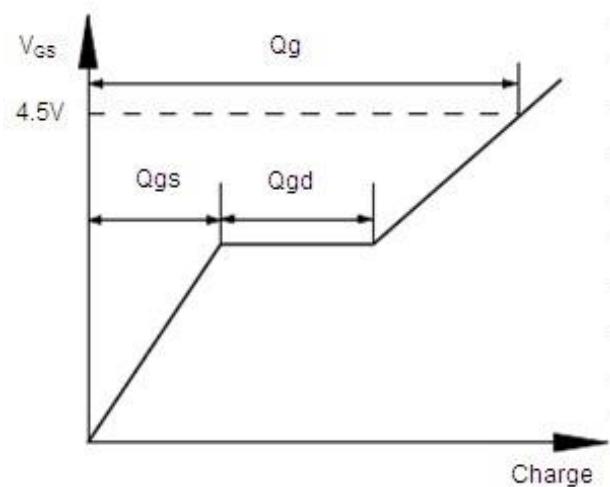
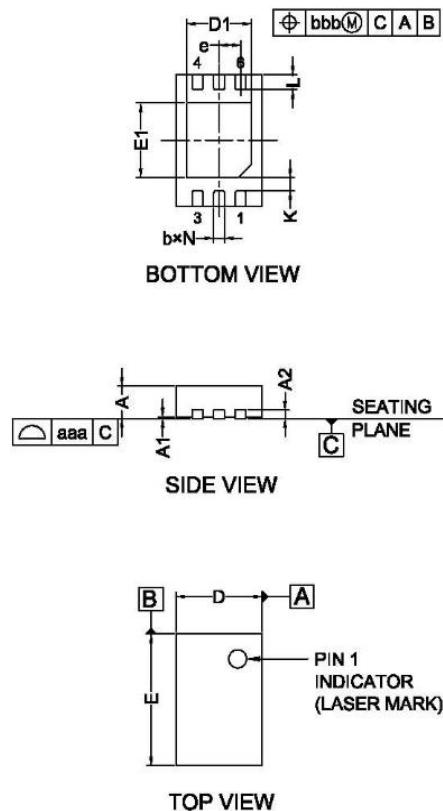


Fig.6 Normalized $R_{DS(on)}$ vs. T_J


Fig.8 Safe Operating Area
Fig.7 Capacitance

Fig.9 Normalized Maximum Transient Thermal Impedance

Fig.10 Switching Time Waveform

Fig.11 Gate Charge Waveform

PACK DFN2*3-6



COMMON DIMENSIONS
(UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	TYP	MAX
A	0.70	0.75	0.80
A1	0.00	0.02	0.05
A2	0.203		
b	0.20	0.25	0.30
D	1.95	2.00	2.05
D1	1.45	1.50	1.55
E	2.95	3.00	3.05
E1	1.65	1.70	1.75
e		0.50BSC	
L	0.30	0.35	0.40
K		0.20MIN	
N		6	
aaa		0.08	
bbb		0.10	

NOTES:

1. CONTROLLING DIMENSIONS ARE IN MILLIMETERS(ANGLES IN DEGREES).
2. COPLANARITY APPLIES TO THE EXPOSED PAD AS THE TERMINALS.